

Welcome to E-XFL.COM

What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	72MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I ² C, IrDA, LINbus, MMC/SD/SDIO, QSPI, SmartCard, SPI, UART/USART, USB
Peripherals	Brown-out Detect/Reset, DMA, LCD, POR, PWM, WDT
Number of I/O	80
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	·
RAM Size	512K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.8V
Data Converters	A/D 16x12b SAR; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	100-TQFP
Supplier Device Package	100-TQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/silicon-labs/efm32gg11b820f2048iq100-b

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

3.2.4 EM2 and EM3 Power Domains

The EFM32GG11 has three independent peripheral power domains for use in EM2 and EM3. Two of these domains are dynamic and can be shut down to save energy. Peripherals associated with the two dynamic power domains are listed in Table 3.1 EM2 and EM3 Peripheral Power Subdomains on page 13. If all of the peripherals in a peripheral power domain are unused, the power domain for that group will be powered off in EM2 and EM3, reducing the overall current consumption of the device. Other EM2, EM3, and EM4-capable peripherals and functions not listed in the table below reside on the primary power domain, which is always on in EM2 and EM3.

Peripheral Power Domain 1	Peripheral Power Domain 2
ACMP0	ACMP1
PCNT0	PCNT1
ADC0	PCNT2
LETIMER0	CSEN
LESENSE	VDAC0
APORT	LEUART0
-	LEUART1
-	LETIMER1
-	12C0
-	12C1
-	12C2
-	IDAC
-	ADC1
-	ACMP2
-	ACMP3
-	LCD
-	RTC

Table 3.1. EM2 and EM3 Peripheral Power Subdomains

3.3 General Purpose Input/Output (GPIO)

EFM32GG11 has up to 144 General Purpose Input/Output pins. GPIO are organized on three independent supply rails, allowing for interface to multiple logic levels in the system simultaneously. Each GPIO pin can be individually configured as either an output or input. More advanced configurations including open-drain, open-source, and glitch-filtering can be configured for each individual GPIO pin. The GPIO pins can be overridden by peripheral connections, like SPI communication. Each peripheral connection can be routed to several GPIO pins on the device. The input value of a GPIO pin can be routed through the Peripheral Reflex System to other peripherals. The GPIO subsystem supports asynchronous external pin interrupts.

3.4 Clocking

3.4.1 Clock Management Unit (CMU)

The Clock Management Unit controls oscillators and clocks in the EFM32GG11. Individual enabling and disabling of clocks to all peripheral modules is performed by the CMU. The CMU also controls enabling and configuration of the oscillators. A high degree of flexibility allows software to optimize energy consumption in any specific application by minimizing power dissipation in unused peripherals and oscillators.

3.5.6 Pulse Counter (PCNT)

The Pulse Counter (PCNT) peripheral can be used for counting pulses on a single input or to decode quadrature encoded inputs. The clock for PCNT is selectable from either an external source on pin PCTNn_S0IN or from an internal timing reference, selectable from among any of the internal oscillators, except the AUXHFRCO. The module may operate in energy mode EM0 Active, EM1 Sleep, EM2 Deep Sleep, and EM3 Stop.

3.5.7 Watchdog Timer (WDOG)

The watchdog timer can act both as an independent watchdog or as a watchdog synchronous with the CPU clock. It has windowed monitoring capabilities, and can generate a reset or different interrupts depending on the failure mode of the system. The watchdog can also monitor autonomous systems driven by PRS.

3.6 Communications and Other Digital Peripherals

3.6.1 Universal Synchronous/Asynchronous Receiver/Transmitter (USART)

The Universal Synchronous/Asynchronous Receiver/Transmitter is a flexible serial I/O module. It supports full duplex asynchronous UART communication with hardware flow control as well as RS-485, SPI, MicroWire and 3-wire. It can also interface with devices supporting:

- ISO7816 SmartCards
- IrDA
- I²S

3.6.2 Universal Asynchronous Receiver/Transmitter (UART)

The Universal Asynchronous Receiver/Transmitter is a subset of the USART module, supporting full duplex asynchronous UART communication with hardware flow control and RS-485.

3.6.3 Low Energy Universal Asynchronous Receiver/Transmitter (LEUART)

The unique LEUARTTM provides two-way UART communication on a strict power budget. Only a 32.768 kHz clock is needed to allow UART communication up to 9600 baud. The LEUART includes all necessary hardware to make asynchronous serial communication possible with a minimum of software intervention and energy consumption.

3.6.4 Inter-Integrated Circuit Interface (I²C)

The I²C module provides an interface between the MCU and a serial I²C bus. It is capable of acting as both a master and a slave and supports multi-master buses. Standard-mode, fast-mode and fast-mode plus speeds are supported, allowing transmission rates from 10 kbit/s up to 1 Mbit/s. Slave arbitration and timeouts are also available, allowing implementation of an SMBus-compliant system. The interface provided to software by the I²C module allows precise timing control of the transmission process and highly automated transfers. Automatic recognition of slave addresses is provided in active and low energy modes.

3.6.5 External Bus Interface (EBI)

The External Bus Interface provides access to external parallel interface devices. The interface is memory mapped into the address bus of the Cortex-M4. This enables seamless access from software without manually manipulating the I/O settings each time a read or write is performed. The data and address lines are multiplexed in order to reduce the number of pins required to interface to external devices. Timing is adjustable to meet specifications of the external devices. The interface is limited to asynchronous devices.

The EBI contains a TFT controller which can drive a TFT via an RGB interface. The TFT controller supports programmable display and port sizes and offers accurate control of frequency and setup and hold timing. Direct Drive is supported for TFT displays which do not have their own frame buffer. In that case TFT Direct Drive can transfer data from either on-chip memory or from an external memory device to the TFT at low CPU load. Automatic alpha-blending and masking is also supported for transfers through the EBI interface.

3.8.4 Capacitive Sense (CSEN)

The CSEN module is a dedicated Capacitive Sensing block for implementing touch-sensitive user interface elements such a switches and sliders. The CSEN module uses a charge ramping measurement technique, which provides robust sensing even in adverse conditions including radiated noise and moisture. The module can be configured to take measurements on a single port pin or scan through multiple pins and store results to memory through DMA. Several channels can also be shorted together to measure the combined capacitance or implement wake-on-touch from very low energy modes. Hardware includes a digital accumulator and an averaging filter, as well as digital threshold comparators to reduce software overhead.

3.8.5 Digital to Analog Current Converter (IDAC)

The Digital to Analog Current Converter can source or sink a configurable constant current. This current can be driven on an output pin or routed to the selected ADC input pin for capacitive sensing. The full-scale current is programmable between 0.05 μ A and 64 μ A with several ranges consisting of various step sizes.

3.8.6 Digital to Analog Converter (VDAC)

The Digital to Analog Converter (VDAC) can convert a digital value to an analog output voltage. The VDAC is a fully differential, 500 ksps, 12-bit converter. The opamps are used in conjunction with the VDAC, to provide output buffering. One opamp is used per singleended channel, or two opamps are used to provide differential outputs. The VDAC may be used for a number of different applications such as sensor interfaces or sound output. The VDAC can generate high-resolution analog signals while the MCU is operating at low frequencies and with low total power consumption. Using DMA and a timer, the VDAC can be used to generate waveforms without any CPU intervention. The VDAC is available in all energy modes down to and including EM3.

3.8.7 Operational Amplifiers

The opamps are low power amplifiers with a high degree of flexibility targeting a wide variety of standard opamp application areas, and are available down to EM3. With flexible built-in programming for gain and interconnection they can be configured to support multiple common opamp functions. All pins are also available externally for filter configurations. Each opamp has a rail to rail input and a rail to rail output. They can be used in conjunction with the VDAC module or in stand-alone configurations. The opamps save energy, PCB space, and cost as compared with standalone opamps because they are integrated on-chip.

3.8.8 Liquid Crystal Display Driver (LCD)

The LCD driver is capable of driving a segmented LCD display with up to 8x36 segments. A voltage boost function enables it to provide the LCD display with higher voltage than the supply voltage for the device. A patented charge redistribution driver can reduce the LCD module supply current by up to 40%. In addition, an animation feature can run custom animations on the LCD display without any CPU intervention. The LCD driver can also remain active even in Energy Mode 2 and provides a Frame Counter interrupt that can wake-up the device on a regular basis for updating data.

3.9 Reset Management Unit (RMU)

The RMU is responsible for handling reset of the EFM32GG11. A wide range of reset sources are available, including several power supply monitors, pin reset, software controlled reset, core lockup reset, and watchdog reset.

3.10 Core and Memory

3.10.1 Processor Core

The ARM Cortex-M processor includes a 32-bit RISC processor integrating the following features and tasks in the system:

- ARM Cortex-M4 RISC processor with FPU achieving 1.25 Dhrystone MIPS/MHz
- Memory Protection Unit (MPU) supporting up to 8 memory segments
- Embedded Trace Macrocell (ETM) for real-time trace and debug
- Up to 2048 kB flash program memory
 - · Dual-bank memory with read-while-write support
- Up to 512 kB RAM data memory
- · Configuration and event handling of all modules
- · 2-pin Serial-Wire or 4-pin JTAG debug interface

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Current consumption in EM0 mode with all peripherals dis-	I _{ACTIVE_LPM}	32 MHz HFRCO, CPU running while loop from flash		82	_	µA/MHz
abled, DCDC in LP mode ³		26 MHz HFRCO, CPU running while loop from flash		83	-	µA/MHz
		16 MHz HFRCO, CPU running while loop from flash	_	88	-	µA/MHz
		1 MHz HFRCO, CPU running while loop from flash		257	-	µA/MHz
Current consumption in EM0 mode with all peripherals dis-	I _{ACTIVE_CCM_VS}	19 MHz HFRCO, CPU running while loop from flash		117	_	µA/MHz
abled and voltage scaling enabled, DCDC in Low Noise CCM mode ¹		1 MHz HFRCO, CPU running while loop from flash	_	1231	_	µA/MHz
Current consumption in EM0 mode with all peripherals dis-	IACTIVE_LPM_VS	19 MHz HFRCO, CPU running while loop from flash		72	_	µA/MHz
enabled, DCDC in LP mode ³		1 MHz HFRCO, CPU running while loop from flash	—	219	_	µA/MHz
Current consumption in EM1	I _{EM1_DCM}	72 MHz HFRCO	_	42	_	µA/MHz
abled, DCDC in Low Noise		50 MHz crystal	—	46	_	µA/MHz
DCM mode ²		48 MHz HFRCO	_	46	_	µA/MHz
		32 MHz HFRCO	_	53	_	µA/MHz
		26 MHz HFRCO		57	_	µA/MHz
		16 MHz HFRCO	_	72	_	µA/MHz
		1 MHz HFRCO	_	663	_	µA/MHz
Current consumption in EM1	I _{EM1_LPM}	32 MHz HFRCO	_	42	_	µA/MHz
abled, DCDC in Low Power		26 MHz HFRCO	_	43	_	µA/MHz
mode ³		16 MHz HFRCO	—	48	_	µA/MHz
		1 MHz HFRCO	_	219	_	µA/MHz
Current consumption in EM1	I _{EM1_DCM_VS}	19 MHz HFRCO		60	_	µA/MHz
mode with all peripherals dis- abled and voltage scaling enabled, DCDC in Low Noise DCM mode ²		1 MHz HFRCO	_	637	_	µA/MHz
Current consumption in EM1	I _{EM1_LPM_VS}	19 MHz HFRCO	_	39	_	µA/MHz
abled and voltage scaling enabled. DCDC in LP mode ³		1 MHz HFRCO		190	_	µA/MHz
Current consumption in EM2 mode, with voltage scaling	I _{EM2_VS}	Full 512 kB RAM retention and RTCC running from LFXO	_	2.8	_	μA
enabled, DCDC in LP mode ³		Full 512 kB RAM retention and RTCC running from LFRCO	_	3.1	_	μA
		16 kB (1 bank) RAM retention and RTCC running from LFRCO ⁵	_	2.1	_	μΑ
Current consumption in EM3 mode, with voltage scaling enabled	I _{EM3_VS}	Full 512 kB RAM retention and CRYOTIMER running from ULFR- CO	_	2.4	_	μA

4.1.10.3 Low-Frequency RC Oscillator (LFRCO)

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Oscillation frequency	f _{LFRCO}	ENVREF ² = 1	TBD	32.768	TBD	kHz
		ENVREF ² = 1, T > 85 °C	TBD	32.768	TBD	kHz
		ENVREF ² = 0	TBD	32.768	TBD	kHz
Startup time	t _{LFRCO}		_	500		μs
Current consumption ¹	I _{LFRCO}	ENVREF = 1 in CMU_LFRCOCTRL	-	370		nA
		ENVREF = 0 in CMU_LFRCOCTRL	-	520		nA
Note:	•					

Table 4.14. Low-Frequency RC Oscillator (LFRCO)

1. Block is supplied by AVDD if ANASW = 0, or DVDD if ANASW=1 in EMU_PWRCTRL register.

2. In CMU_LFRCOCTRL register.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
Note:	·		·					
1. Specified configuratio V. Nominal voltage ga	n for 3X-Gain con iin is 3.	figuration is: INCBW = 1, HCM	/IDIS = 1, RESINSEL =	VSS, V _{INPUT} =	= 0.5 V, V _{OUT}	_{PUT} = 1.5		
2. If the maximum C _{LOA}	_D is exceeded, an	isolation resistor is required for	or stability. See AN0038	3 for more infor	mation.			
3. When INCBW is set to or the OPAMP may n	o 1 the OPAMP ba ot be stable.	andwidth is increased. This is	allowed only when the r	non-inverting c	lose-loop gai	n is ≥ 3,		
4. Current into the load drive the resistor feed another ~10 μA curre	esistor is exclude back network. The nt when the OPAN	d. When the OPAMP is conne e internal resistor feedback ne /IP drives 1.5 V between outp	ected with closed-loop g twork has total resistan ut and ground.	ain > 1, there v ce of 143.5 kC	will be extra c 0hm, which wi	urrent to Il cause		
5. Step between 0.2V ar	nd V _{OPA} -0.2V, 10%	%-90% rising/falling range.						
6. From enable to outpu	t settled. In sample	e-and-off mode, RC network a	after OPAMP will contrib	oute extra dela	y. Settling err	or < 1mV.		
7. In unit gain connectio product of the OPAMI	n, UGF is the gain P and 1/3 attenuat	l-bandwidth product of the OP tion of the feedback network.	AMP. In 3x Gain conne	ction, UGF is t	he gain-band	width		
8. Specified configuratio V _{OUTPUT} = 0.5 V.	8. Specified configuration for Unit gain buffer configuration is: INCBW = 0, HCMDIS = 0, RESINSEL = DISABLE. V _{INPUT} = 0.5 V, V _{OUTPUT} = 0.5 V.							
9. When HCMDIS=1 and and CMRR specificati	d input common m	node transitions the region from to this transition region.	m V _{OPA} -1.4V to V _{OPA} -1	V, input offset	will change. F	PSRR		

4.1.20 LCD Driver

Table 4.28. LCD Driver

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Frame rate	f _{LCDFR}		TBD	_	TBD	Hz
LCD supply range ²	V _{LCDIN}		1.8		3.8	V
LCD output voltage range	V _{LCD}	Current source mode, No external LCD capacitor	2.0	_	V _{LCDIN} -0.4	V
		Step-down mode with external LCD capacitor	2.0	—	V _{LCDIN}	V
		Charge pump mode with external LCD capacitor	2.0	—	1.9 * V _{LCDIN}	V
Contrast control step size	STEP _{CONTRAST}	Current source mode	_	64	—	mV
		Charge pump or Step-down mode		43	—	mV
Contrast control step accura- cy ¹	ACC _{CONTRAST}		—	+/-4	_	%

Note:

1. Step size accuracy is measured relative to the typical step size, and typ value represents one standard deviation.

2. V_{LCDIN} is selectable between the AVDD or DVDD supply pins, depending on EMU_PWRCTRL_ANASW.



Figure 4.3. EBI Write Enable Output Timing Diagram

EBI Address Latch Enable Output Timing

Timing applies to multiplexed addressing modes D8A24ALE and D16A16ALE for both polarities. All numbers are based on route locations 0,1,2 only (with all EBI alternate functions using the same location at the same time). Timing is specified at 10% and 90% of IOVDD, 25 pF external loading, and slew rate for all GPIO set to 6.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Output hold time, from trail- ing EBI_ALE edge to EBI_AD invalid ^{1 2}	t _{OH_ALEn}	IOVDD ≥ 1.62 V	-22 + (ADDR- HOLD * ^t HFCOR- ECLK)	_	—	ns
		IOVDD ≥ 3.0 V	-11 + (ADDR- HOLD * ^t HFCOR- ECLK)	_	_	ns
Output setup time, from	t _{OSU_ALEn}	IOVDD ≥ 1.62 V	-12	_		ns
EBI_AD valid to leading EBI_ALE edge		IOVDD ≥ 3.0 V	-9	_		ns
EBI_ALEn pulse width ¹	twiDTH_ALEn	IOVDD ≥ 1.62 V	-4 + ((ADDR- SETUP + 1) * t{ _{}HFCOR-} ECLK{})	_	_	ns
		IOVDD ≥ 3.0 V	-3 + ((ADDR- SETUP + 1) * t{ _{}HFCOR-} ECLK{})	—	_	ns

Table 4.37. EBI Address Latch Enable Output Timing

Note:

1. The figure shows the timing for the case that the half strobe length functionality is not used, i.e. HALFALE=0. The trailing edge of EBI_ALEn can be moved to the left by setting HALFALE=1. This decreases the length of t_{WIDTH_ALEn} and increases the length of t_{OSU_ALEn} by t_{HFCORECLK} - 1/2 * t_{HFCLKNODIV}.

2. The figure shows a write operation. For a multiplexed read operation the address hold time is controlled via the RDSETUP state instead of via the ADDRHOLD state.

EBI Read Enable Output Timing

Timing applies to both EBI_REn and EBI_NANDREn for all addressing modes and both polarities. Output timing for EBI_AD applies only to multiplexed addressing modes D8A24ALE and D16A16ALE. All numbers are based on route locations 0,1,2 only (with all EBI alternate functions using the same location at the same time). Timing is specified at 10% and 90% of IOVDD, 25 pF external loading, and slew rate for all GPIO set to 6.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Output hold time, from trail- ing EBI_REn / EBI_NAN- DREn edge to EBI_AD, EBI_A, EBI_CSn, EBI_BLn invalid	^t OH_REn	IOVDD ≥ 1.62 V	-23 + (RDHOLD * t _{HFCOR-} ECLK)		_	ns
		IOVDD ≥ 3.0 V	-13 + (RDHOLD * t _{HFCOR-} ECLK)	_	—	ns
Output setup time, from EBI_AD, EBI_A, EBI_CSn, EBI_BLn valid to leading EBI_REn / EBI_NANDREn	tosu_ren	IOVDD ≥ 1.62 V	-12 + (RDSETUP * t _{HFCOR-} ECLK)	_		ns
euge .		IOVDD ≥ 3.0 V	-11 + (RDSETUP * t _{HFCOR- ECLK})	_		ns
EBI_REn pulse width ^{1 2}	^t WIDTH_REn	IOVDD ≥ 1.62 V	-6 + (MAX(1, RDSTRB) * t _{HFCOR-} ECLK)		_	ns
		IOVDD ≥ 3.0 V	-4 + (MAX(1, RDSTRB) * t _{HFCOR} - _{ECLK})	_	_	ns

Table 4.38. EBI Read Enable Output Timing

Note:

1. The figure shows the timing for the case that the half strobe length functionality is not used, i.e. HALFRE=0. The leading edge of EBI_REn can be moved to the right by setting HALFRE=1. This decreases the length of t_{WIDTH_REn} and increases the length of t_{OSU_REn} by 1/2 * t_{HFCLKNODIV}.

2. When page mode is used, RDSTRB is replaced by RDPA for page hits.

EBI TFT Output Timing

All numbers are based on route locations 0,1,2 only (with all EBI alternate functions using the same location at the same time). Timing is specified at 10% and 90% of IOVDD, 25 pF external loading, and slew rate for all GPIO set to 6.

Table 4.39. EBI TFT Output Timing

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Output hold time, EBI_DCLK to EBI_AD invalid	toh_dclk	IOVDD ≥ 1.62 V	-23 + (TFTHOLD ^{* t} нғсоя- есік)	_	_	ns
		IOVDD ≥ 3.0 V	-12 + (TFTHOLD ^{* t} нFCOR- ECLK)	_		ns
Output setup time, EBI_AD valid to EBI_DCLK	tosu_dclk	IOVDD ≥ 1.62 V	-11 + (TFTSET- UP * ^t HFCOR- ECLK)	_	_	ns
		IOVDD ≥ 3.0 V	-9 + (TFTSET- UP * t _{HFCOR-} ECLK)	_	_	ns



Figure 4.6. EBI TFT Output Timing

SDIO SDR Mode Timing

Timing is specified for route location 0 at 1.8 V IOVDD with voltage scaling disabled. Slew rate for SD_CLK set to 7, all other GPIO set to 6, DRIVESTRENGTH = STRONG for all pins. SDIO_CTRL_TXDLYMUXSEL = 0. Loading between 5 and 10 pF on all pins or between 10 and 40 pF on all pins.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Clock frequency during data transfer	F _{SD_CLK}	Using HFRCO, AUXHFRCO, or USHFRCO	_	_	20	MHz
		Using HFXO	_	_	TBD	MHz
Clock low time	t _{WL}	Using HFRCO, AUXHFRCO, or USHFRCO	22.6			ns
		Using HFXO	TBD	—	_	ns
Clock high time	t _{WH}	Using HFRCO, AUXHFRCO, or USHFRCO	22.6	_	_	ns
		Using HFXO	TBD	_	_	ns
Clock rise time	t _R		0.99	4.68	_	ns
Clock fall time	t _F		0.90	3.64	_	ns
Input setup time, CMD, DAT[0:3] valid to SD_CLK	t _{ISU}		8	_		ns
Input hold time, SD_CLK to CMD, DAT[0:3] change	t _{IH}		1.5	_		ns
Output delay time, SD_CLK to CMD, DAT[0:3] valid	t _{ODLY}		0	—	35	ns
Output hold time, SD_CLK to CMD, DAT[0:3] change	t _{OH}		0.8	_	_	ns

Table 4.48. SDIO SDR Mode Timing (Location 0)

SDIO MMC DDR Mode Timing at 1.8 V

Timing is specified for route location 0 at 1.8 V IOVDD with voltage scaling disabled. Slew rate for SD_CLK set to 7, all other GPIO set to 6, DRIVESTRENGTH = STRONG for all pins. SDIO_CTRL_TXDLYMUXSEL = 1. Loading between 5 and 10 pF on all pins or between 10 and 25 pF on all pins.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Clock frequency during data transfer	F _{SD_CLK}	Using HFRCO, AUXHFRCO, or USHFRCO	—	_	18	MHz
		Using HFXO	_		TBD	MHz
Clock low time	t _{WL}	Using HFRCO, AUXHFRCO, or USHFRCO	25.1			ns
		Using HFXO	TBD	—	_	ns
Clock high time	t _{WH}	Using HFRCO, AUXHFRCO, or USHFRCO	25.1	_	_	ns
		Using HFXO	TBD	_	_	ns
Clock rise time	t _R		1.13	5.21	—	ns
Clock fall time	t _F		1.01	4.10	_	ns
Input setup time, CMD valid to SD_CLK	t _{ISU}		5.3	_	_	ns
Input hold time, SD_CLK to CMD change	t _{IH}		2.5	_	_	ns
Output delay time, SD_CLK to CMD valid	t _{ODLY}		0	_	16	ns
Output hold time, SD_CLK to CMD change	t _{OH}		3			ns
Input setup time, DAT[0:7] valid to SD_CLK	t _{ISU2X}		5.3			ns
Input hold time, SD_CLK to DAT[0:7] change	t _{IH2X}		2.5	—	_	ns
Output delay time, SD_CLK to DAT[0:7] valid	t _{ODLY2X}		0		16	ns
Output hold time, SD_CLK to DAT[0:7] change	t _{OH2X}		3			ns

Table 4.52. SDIO MMC DDR Mode Timing (Location 0, 1.8V I/O)

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PF3	79	GPIO	PF4	80	GPIO
PF5	81	GPIO	PF6	84	GPIO
PF7	85	GPIO	PF8	86	GPIO
PF9	87	GPIO	PD9	88	GPIO
PD10	89	GPIO	PD11	90	GPIO
PD12	91	GPIO	PE8	92	GPIO
PE9	93	GPIO	PE10	94	GPIO
PE11	95	GPIO	PE12	96	GPIO
PE13	97	GPIO	PE14	98	GPIO
PE15	99	GPIO	PA15	100	GPIO
NUM					

Note:

1. GPIO with 5V tolerance are indicated by (5V).

GPIO Name	Pin Alternate Functionality / Description							
	Analog	EBI	Communication	Other				
PD15		EBI_NANDREn #1	TIM2_CDTI2 #1 TIM3_CC0 #7 WTIM0_CDTI0 #1 PCNT1_S0IN #2	ETH_TSUEXTCLK #1 CAN0_TX #5 US5_CTS #1 I2C0_SCL #3				
PC13	VDAC0_OUT1ALT / OPA1_OUTALT #1 BUSACMP1Y BU- SACMP1X	EBI_ARDY #4	TIM0_CDTI0 #1 TIM1_CC0 #0 TIM1_CC2 #4 TIM5_CC2 #5 WTIM3_CC2 #2 PCNT0_S0IN #0 PCNT2_S1IN #4	US0_CTS #3 US1_RTS #4 US2_RTS #4 U0_CTS #3 U1_RX #0 I2C2_SCL #6	LES_CH13 PRS_CH21 #1 ACMP3_O #3			
PC12	VDAC0_OUT1ALT / OPA1_OUTALT #0 BUSACMP1Y BU- SACMP1X		TIM1_CC3 #0 TIM5_CC1 #5 WTIM3_CC1 #2 PCNT2_S0IN #4	CAN1_RX #4 US0_RTS #3 US1_CTS #4 US2_CTS #4 U0_RTS #3 U1_TX #0 I2C2_SDA #6	CMU_CLK0 #1 LES_CH12 PRS_CH20 #1			
PC11	BUSACMP1Y BU- SACMP1X	EBI_ALE #4 EBI_ALE #5 EBI_A23 #1	TIM5_CC0 #5 WTIM3_CC0 #2	CAN1_TX #4 US0_TX #2 I2C1_SDA #4	LES_CH11 PRS_CH19 #1			
PA3	BUSAY BUSBX LCD_SEG16	EBI_AD12 #0 EBI_VSNC #3	TIM0_CDTI0 #0 TIM3_CC0 #5	ETH_RMIIREFCLK #0 ETH_MIITXD1 #0 SDIO_DAT3 #1 US3_CS #0 U0_TX #2 QSPI0_DQ1 #1	CMU_CLK2 #1 CMU_CLK10 #1 CMU_CLK2 #4 LES_ALTEX2 PRS_CH9 #1 ETM_TD1 #3			
PG2	BUSACMP2Y BU- SACMP2X	EBI_AD02 #2	TIM6_CC2 #0 TIM2_CDTI2 #3 WTIM0_CC0 #2 LE- TIM1_OUT0 #7	ETH_MIITXD2 #1 US3_CLK #4 QSPI0_DQ1 #2	CMU_CLK0 #3			
PG1	BUSACMP2Y BU- SACMP2X	EBI_AD01 #2	TIM6_CC1 #0 TIM2_CDTI1 #3 WTIM0_CDTI2 #1 LETIM1_OUT1 #6	ETH_MIITXD3 #1 US3_RX #4 QSPI0_DQ0 #2	CMU_CLK1 #3			
PC10	BUSACMP1Y BU- SACMP1X	EBI_A10 #2 EBI_A22 #1	TIM2_CC2 #2 TIM5_CC2 #4 WTIM3_CC2 #1	CAN1_TX #3 US0_RX #2	LES_CH10 PRS_CH18 #1			
PC9	BUSACMP1Y BU- SACMP1X	EBI_A09 #2 EBI_A21 #1 EBI_A27 #3	TIM2_CC1 #2 TIM5_CC1 #4 WTIM3_CC1 #1	CAN1_RX #3 US0_CLK #2	LES_CH9 PRS_CH5 #0 GPIO_EM4WU2			
PC8	BUSACMP1Y BU- SACMP1X	EBI_A08 #2 EBI_A15 #0 EBI_A20 #1 EBI_A26 #3	TIM2_CC0 #2 TIM5_CC0 #4 WTIM3_CC0 #1	US0_CS #2	LES_CH8 PRS_CH4 #0			
PA4	BUSBY BUSAX LCD_SEG17	EBI_AD13 #0 EBI_HSNC #3	TIM0_CDTI1 #0 TIM3_CC1 #5	ETH_RMIICRSDV #0 ETH_MIITXD0 #0 SDIO_DAT4 #1 US3_CTS #0 U0_RX #2 QSPI0_DQ2 #1	LES_ALTEX3 PRS_CH16 #0 ETM_TD2 #3			
PG4	BUSACMP2Y BU- SACMP2X	EBI_AD04 #2	TIM6_CDTI1 #0 WTIM0_CC2 #2	ETH_MIITXD0 #1 US3_CTS #4 QSPI0_DQ3 #2				

Alternate	LOCA		
Functionality	0 - 3	4 - 7	Description
EBI_A10	0: PE3 1: PD6 2: PC10 3: PB10		External Bus Interface (EBI) address output pin 10.
EBI_A11	0: PE4 1: PD7 2: PI6 3: PB11		External Bus Interface (EBI) address output pin 11.
EBI_A12	0: PE5 1: PD8 2: PI7 3: PB12		External Bus Interface (EBI) address output pin 12.
EBI_A13	0: PE6 1: PC7 2: PI8 3: PD0		External Bus Interface (EBI) address output pin 13.
EBI_A14	0: PE7 1: PE2 2: PI9 3: PD1		External Bus Interface (EBI) address output pin 14.
EBI_A15	0: PC8 1: PE3 2: PI10 3: PD2		External Bus Interface (EBI) address output pin 15.
EBI_A16	0: PB0 1: PE4 2: PH4 3: PD3		External Bus Interface (EBI) address output pin 16.
EBI_A17	0: PB1 1: PE5 2: PH5 3: PD4		External Bus Interface (EBI) address output pin 17.
EBI_A18	0: PB2 1: PE6 2: PH6 3: PD5		External Bus Interface (EBI) address output pin 18.
EBI_A19	0: PB3 1: PE7 2: PH7 3: PD6		External Bus Interface (EBI) address output pin 19.
EBI_A20	0: PB4 1: PC8 2: PH8 3: PD7		External Bus Interface (EBI) address output pin 20.
EBI_A21	0: PB5 1: PC9 2: PH9 3: PC7		External Bus Interface (EBI) address output pin 21.
EBI_A22	0: PB6 1: PC10 2: PH10 3: PE4		External Bus Interface (EBI) address output pin 22.

Alternate	LOCA	ATION	
Functionality	0 - 3	4 - 7	Description
EBI_AD08	0: PA15 1: PC1 2: PG8		External Bus Interface (EBI) address and data input / output pin 08.
EBI_AD09	0: PA0 1: PC2 2: PG9		External Bus Interface (EBI) address and data input / output pin 09.
EBI_AD10	0: PA1 1: PC3 2: PG10		External Bus Interface (EBI) address and data input / output pin 10.
EBI_AD11	0: PA2 1: PC4 2: PG11		External Bus Interface (EBI) address and data input / output pin 11.
EBI_AD12	0: PA3 1: PC5 2: PG12		External Bus Interface (EBI) address and data input / output pin 12.
EBI_AD13	0: PA4 1: PA7 2: PG13		External Bus Interface (EBI) address and data input / output pin 13.
EBI_AD14	0: PA5 1: PA8 2: PG14		External Bus Interface (EBI) address and data input / output pin 14.
EBI_AD15	0: PA6 1: PA9 2: PG15		External Bus Interface (EBI) address and data input / output pin 15.
EBI_ALE	0: PF3 1: PB9 2: PC4 3: PB5	4: PC11 5: PC11	External Bus Interface (EBI) Address Latch Enable output.
EBI_ARDY	0: PF2 1: PD13 2: PB15 3: PB4	4: PC13 5: PF10	External Bus Interface (EBI) Hardware Ready Control input.
EBI_BL0	0: PF6 1: PF8 2: PB10 3: PC1	4: PF6 5: PF6	External Bus Interface (EBI) Byte Lane/Enable pin 0.
EBI_BL1	0: PF7 1: PF9 2: PB11 3: PC3	4: PF7 5: PF7	External Bus Interface (EBI) Byte Lane/Enable pin 1.
EBI_CS0	0: PD9 1: PA10 2: PC0 3: PB0	4: PE8	External Bus Interface (EBI) Chip Select output 0.

Alternate Functionality	Location	Priority							
QSPI0_DQS	0: PF9	High Speed							
QSPI0_SCLK	0: PF6	High Speed							
SDIO_CLK	0: PE13	High Speed							
SDIO_CMD	0: PE12	High Speed							
SDIO_DAT0	0: PE11	High Speed							
SDIO_DAT1	0: PE10	High Speed							
SDIO_DAT2	0: PE9	High Speed							
SDIO_DAT3	0: PE8	High Speed							
SDIO_DAT4	0: PD12	High Speed							
SDIO_DAT5	0: PD11	High Speed							
SDIO_DAT6	0: PD10	High Speed							
SDIO_DAT7	0: PD9	High Speed							
TIM0_CC0	3: PB6	Non-interference							
TIM0_CC1	3: PC0	Non-interference							
TIM0_CC2	3: PC1	Non-interference							
TIM0_CDTI0	1: PC13	Non-interference							
TIM0_CDTI1	1: PC14	Non-interference							
TIM0_CDTI2	1: PC15	Non-interference							
TIM2_CC0	0: PA8	Non-interference							
TIM2_CC1	0: PA9	Non-interference							
TIM2_CC2	0: PA10	Non-interference							
TIM2_CDTI0	0: PB0	Non-interference							
TIM2_CDTI1	0: PB1	Non-interference							
TIM2_CDTI2	0: PB2	Non-interference							
TIM4_CC0	0: PF3	Non-interference							
TIM4_CC1	0: PF4	Non-interference							
TIM4_CC2	0: PF12	Non-interference							
TIM4_CDTI0	0: PD0	Non-interference							
TIM4_CDTI1	0: PD1	Non-interference							
TIM4_CDTI2	0: PD3	Non-interference							
TIM6_CC0	0: PG0	Non-interference							
TIM6_CC1	0: PG1	Non-interference							
TIM6_CC2	0: PG2	Non-interference							
TIM6_CDTI0	0: PG3	Non-interference							
TIM6_CDTI1	0: PG4	Non-interference							
TIM6_CDTI2	0: PG5	Non-interference							

EFM32GG11 Family Data Sheet Pin Definitions

Port	Bus	CH31	CH30	CH29	CH28	CH27	CH26	CH25	CH24	CH23	CH22	CH21	CH20	CH19	CH18	CH17	CH16	CH15	CH14	CH13	CH12	CH11	CH10	CH9	CH8	CH7	CH6	CH5	CH4	CH3	CH2	CH1	CH0
ОР	A2_	<u>_</u> OU [.]	т																														
APORT1Y	BUSAY	PB15		PB13		PB11		PB9				PB5		PB3		PB1		PA15		PA13		PA11		PA9		PA7		PA5		PA3		PA1	
APORT2Y	BUSBY		PB14		PB12		PB10				PB6		PB4		PB2		PB0		PA14		PA12		PA10		PA8		PA6		PA4		PA2		PAO
APORT3Y	BUSCY	PF15		PF13		PF11		PF9		PF7		PF5		PF3		PF1		PE15		PE13		PE11		PE9		PE7		PE5				PE1	
APORT4Y	BUSDY		PF14		PF12		PF10		PF8		PF6		PF4		PF2		PF0		PE14		PE12		PE10		PE8		PE6		PE4				PE0
OP	A2_	P																															
APORT1X	BUSAX		PB14		PB12		PB10				PB6		PB4		PB2		PBO		PA14		PA12		PA10		PA8		PA6		PA4		PA2		PA0
APORT2X	BUSBX	PB15		PB13		PB11		PB9				PB5		PB3		PB1		PA15		PA13		PA11		PA9		PA7		PA5		PA3		PA1	
APORT3X	BUSCX		PF14		PF12		PF10		PF8		PF6		PF4		PF2		PF0		PE14		PE12		PE10		PE8		PE6		PE4				PEO
APORT4X	BUSDX	PF15		PF13		PF11		PF9		PF7		PF5		PF3		PF1		PE15		PE13		PE11		PE9		PE7		PE5				PE1	
OP	A3_	N																															
APORT1Y	BUSAY	PB15		PB13		PB11		PB9				PB5		PB3		PB1		PA15		PA13		PA11		PA9		PA7		PA5		PA3		PA1	
APORT2Y	BUSBY		PB14		PB12		PB10				PB6		PB4		PB2		PB0		PA14		PA12		PA10		PA8		PA6		PA4		PA2		PA0
APORT3Y	BUSCY	PF15		PF13		PF11		PF9		PF7		PF5		PF3		PF1		PE15		PE13		PE11		PE9		PE7		PE5				PE1	
APORT4Y	BUSDY		PF14		PF12		PF10		PF8		PF6		PF4		PF2		PF0		PE14		PE12		PE10		PE8		PE6		PE4				PEO

Table 7.2. BGA152 PCB Land Pattern Dimensions

Dimension	Min	Мах								
X		0.20								
C1	6.50									
C2		6.50								
E1		0.5								
E2		0.5								

Note:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.

2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.

3. This Land Pattern Design is based on the IPC-7351 guidelines.

4. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 μm minimum, all the way around the pad.

5. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.

6. The stencil thickness should be 0.125 mm (5 mils).

7. The ratio of stencil aperture to land pad size should be 1:1.

8. A No-Clean, Type-3 solder paste is recommended.

9. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

13. Revision History

Revision 0.6

March, 2018

- Removed "Confindential" watermark.
- · Updated 4.1 Electrical Characteristics and 4.2 Typical Performance Curves with latest characterization data.

Revision 0.2

October, 2017

- · Updated memory maps to latest formatting and to include all peripherals.
- Updated all electrical specifications tables with latest characterization results.
- Absolute Maximum Ratings Table:
 - Removed redundant I_{VSSMAX} line.
 - Added footnote to clarify V_{DIGPIN} specification for 5V tolerant GPIO.
- General Operating Conditions Table:
 - Removed dV_{DD} specification and redundant footnote about shorting VREGVDD and AVDD together.
 - Added footnote about IOVDD voltage restriction when CSEN peripheral is used with chopping enabled.
- Flash Memory Characteristics Table: Added timing measurement clarification for Device Erase and Mass Erase.
- · Analog to Digital Converter (ADC) Table:
 - · Added header text for general specification conditions.
 - Added footnote for clarification of input voltage limits.
- · Minor typographical corrections, including capitalization, mis-spellings and punctuation marks, throughout document.
- Minor formatting and styling updates, including table formats, TOC location, and boilerplate information throughout document.

Revision 0.1

April 27th, 2017

Initial release.